



JEOL JWS-7505



- Review Scanning Electron Microscope (SEM)
- Able to communicate with KLA 2552
- Currently set up for 8" wafers
- 5" & 6" wafer capable
- Autoloader
- Stage Tilt -15° to 60°, Rotation 360°, & Z:fixed
- Resolution: 8nm (@ accelerating voltage of 1kV)
- Magnification: x100 to 200,000 (on the CRT display)
- Accelerating Voltage:
 - 0.5kV to 3kV in 10V steps
 - 3kV to 6kV in 100V steps